

64/32 Kbit Serial I2C Bus EEPROM

- Two Wire I²C Serial Interface Supports 400 kHz Protocol
- Single Supply Voltage:
 - 4.5V to 5.5V for M24Cxx
 - 2.5V to 5.5V for M24Cxx-W
 - 1.8V to 5.5V for M24Cxx-R
 - 1.8V to 3.6V for M24Cxx-S
- Write Control Input
- BYTE and PAGE WRITE (up to 32 Bytes)
- RANDOM and SEQUENTIAL READ Modes
- Self-Timed Programming Cycle
- Automatic Address Incrementing
- Enhanced ESD/Latch-Up Behavior
- More than 1M Erase/Write Cycles
- More than 40 Year Data Retention

DESCRIPTION

These I²C-compatible electrically erasable programmable memory (EEPROM) devices are organised as 8192x8 bits (M24C64) and 4096x8 bits (M24C32), and operate down to 2.5 V (for the -W version), and down to 1.8 V (for the -R and -S versions).

These devices are compatible with the I²C memory protocol. This is a two wire serial interface that uses a bi-directional data bus and serial clock. The devices carry a built-in 4-bit Device Type

Table 1. Signal Names

E0, E1, E2	Chip Enable
SDA	Serial Data
SCL	Serial Clock
WC	Write Control
Vcc	Supply Voltage
Vss	Ground

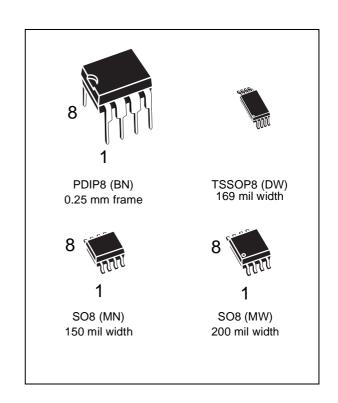
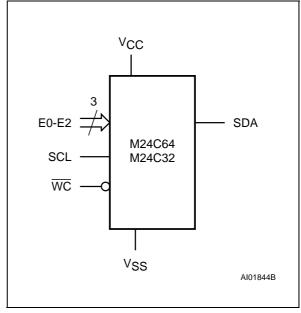


Figure 1. Logic Diagram



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Figure 2A. DIP Connections

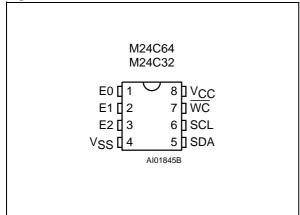
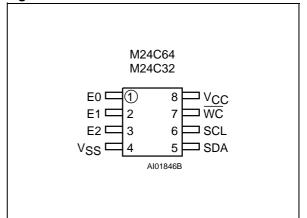


Figure 2B. SO and TSSOP Connections



Identifier code (1010) in accordance with the I²C bus definition.

The device behaves as a slave in the I^2C protocol, with all memory operations synchronized by the serial clock. Read and Write operations are initiated by a Start condition, generated by the bus master. The Start condition is followed by a Device Select Code and $R\overline{W}$ bit (as described in Table 3), terminated by an acknowledge bit.

When writing data to the memory, the device inserts an acknowledge bit during the 9th bit time, following the bus master's 8-bit transmission. When data is read by the bus master, the bus master acknowledges the receipt of the data byte in the same way. Data transfers are terminated by a Stop condition after an Ack for Write, and after a NoAck for Read.

Power On Reset: V_{CC} Lock-Out Write Protect

In order to prevent data corruption and inadvertent Write operations during Power-up, a Power On Reset (POR) circuit is included. The internal reset is held active until V_{CC} has reached the POR threshold value, and all operations are disabled – the device will not respond to any command. In the same way, when V_{CC} drops from the operating voltage, below the POR threshold value, all operations are disabled and the device will not respond to any command. A stable and valid V_{CC} must be applied before applying any logic signal.

SIGNAL DESCRIPTION Serial Clock (SCL)

This input signal is used to strobe all data in and out of the device. In applications where this signal is used by slave devices to synchronize the bus to

Table 2. Absolute Maximum Ratings ¹

Symbol	Pa	Parameter			
T _A	Ambient Operating Temperatu	re	-40 to 125	°C	
T _{STG}	Storage Temperature		-65 to 150	°C	
T_LEAD	Lead Temperature during Soldering	PDIP8: 10 seconds SO8: 20 seconds (max) ² TSSOP8: 20 seconds (max) ²	260 235 235	°C	
V _{IO}	Input or Output range		-0.6 to 6.5	V	
Vcc	Supply Voltage		-0.3 to 6.5	V	
V _{ESD}	Electrostatic Discharge Voltage	e (Human Body model) ³	4000	V	

Note: 1. Except for the rating "Operating Temperature Range", stresses above those listed in the Table "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the ST SURE Program and other relevant quality documents.

2. IPC/JEDEC J-STD-020A

3. JEDEC Std JESD22-A114A (C1=100 pF, R1=1500 Ω , R2=500 Ω)

a slower clock, the bus master must have an open drain output, and a pull-up resistor must be connected from Serial Clock (SCL) to V_{CC} . (Figure 3 indicates how the value of the pull-up resistor can be calculated). In most applications, though, this method of synchronization is not employed, and so the pull-up resistor is not necessary, provided that the bus master has a push-pull (rather than open drain) output.

Serial Data (SDA)

This bi-directional signal is used to transfer data in or out of the device. It is an open drain output that may be wire-OR'ed with other open drain or open collector signals on the bus. A pull up resistor must be connected from Serial Data (SDA) to V_{CC} . (Figure 3 indicates how the value of the pull-up resistor can be calculated).

Chip Enable (E0, E1, E2)

These input signals are used to set the value that is to be looked for on the three least significant bits (b3, b2, b1) of the 7-bit Device Select Code. These inputs must be tied to V_{CC} or V_{SS} , to establish the Device Select Code.

Write Control (WC)

This input signal is useful for protecting the entire contents of the memory from inadvertent write operations. Write operations are disabled to the entire memory array when Write Control (WC) is driven High. When unconnected, the signal is

internally read as V_{IL} , and Write operations are allowed.

When Write Control (\overline{WC}) is driven High, Device Select and Address bytes are acknowledged, Data bytes are not acknowledged.

DEVICE OPERATION

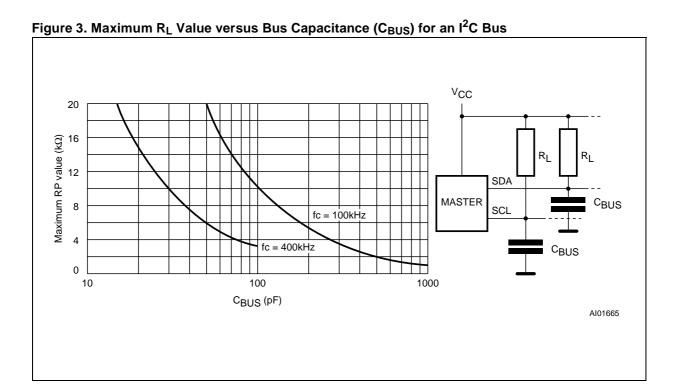
The device supports the I²C protocol. This is summarized in Figure 4. Any device that sends data on to the bus is defined to be a transmitter, and any device that reads the data to be a receiver. The device that controls the data transfer is known as the bus master, and the other as the slave device. A data transfer can only be initiated by the bus master, which will also provide the serial clock for synchronization. The M24Cxx device is always a slave in all communication.

Start Condition

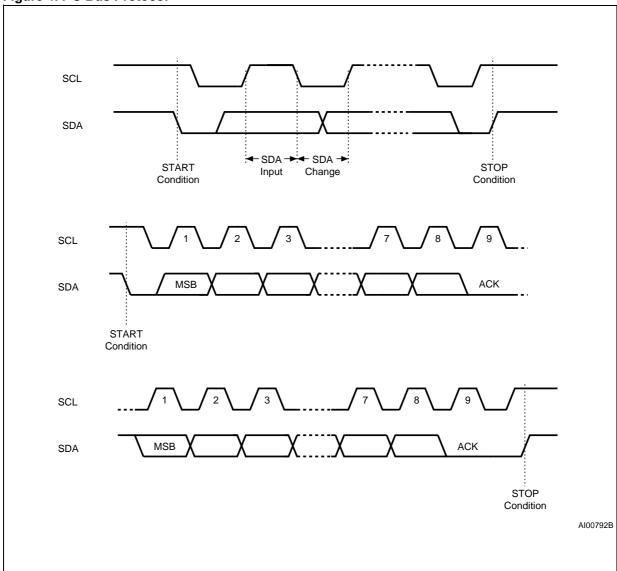
Start is identified by a falling edge of Serial Data (SDA) while Serial Clock (SCL) is stable in the High state. A Start condition must precede any data transfer command. The device continuously monitors (except during a Write cycle) Serial Data (SDA) and Serial Clock (SCL) for a Start condition, and will not respond unless one is given.

Stop Condition

Stop is identified by a rising edge of Serial Data (SDA) while Serial Clock (SCL) is stable and driven High. A Stop condition terminates







communication between the device and the bus master. A Read command that is followed by NoAck can be followed by a Stop condition to force the device into the Stand-by mode. A Stop condition at the end of a Write command triggers the internal EEPROM Write cycle.

Acknowledge Bit (ACK)

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The acknowledge bit is used to indicate a successful byte transfer. The bus transmitter, whether it be bus master or slave device, releases Serial Data (SDA) after sending eight bits of data. During the 9th clock pulse period, the receiver pulls Serial Data (SDA) Low to acknowledge the receipt of the eight data bits.

Data Input

During data input, the device samples Serial Data (SDA) on the rising edge of Serial Clock (SCL). For correct device operation, Serial Data (SDA) must be stable during the rising edge of Serial Clock (SCL), and the Serial Data (SDA) signal must change *only* when Serial Clock (SCL) is driven Low.

Memory Addressing

To start communication between the bus master and the slave device, the bus master must initiate a Start condition. Following this, the bus master sends the Device Select Code, shown in Table 3 (on Serial Data (SDA), most significant bit first).

Table 3. Device Select Code 1

	Device Type Identifier				Chip	Enable Add	dress	R₩
	b7 b6 b5 b4				b3	b2	b1	b0
Device Select Code	1	0	1	0	E2	E1	E0	R₩

Note: 1. The most significant bit, b7, is sent first.

The Device Select Code consists of a 4-bit Device Type Identifier, and a 3-bit Chip Enable "Address" (E2, E1, E0). To address the memory array, the 4-bit Device Type Identifier is 1010b.

Up to eight memory devices can be connected on a single I²C bus. Each one is given a unique 3-bit code on the Chip Enable (E0, E1, E2) inputs. When the Device Select Code is received on Serial Data (SDA), the device only responds if the Chip Enable Address is the same as the value on the Chip Enable (E0, E1, E2) inputs.

The 8^{th} bit is the Read/Write bit (RW). This bit is set to 1 for Read and 0 for Write operations.

If a match occurs on the Device Select code, the corresponding device gives an acknowledgment on Serial Data (SDA) during the 9th bit time. If the device does not match the Device Select code, it deselects itself from the bus, and goes into Standby mode.

Write Operations

Following a Start condition the bus master sends a Device Select Code with the RW bit reset to 0. The device acknowledges this, as shown in Figure 6, and waits for two address bytes. The device responds to each address byte with an acknowledge bit, and then waits for the data byte. Writing to the memory may be inhibited if Write Control (WC) is driven High. Any Write instruction with Write Control (WC) driven High (during a period of time from the Start condition until the end of the two address bytes) will not modify the

Table 4. Most Significant Byte

b15	b14	b13	b12	b11	b10	b9	b8
-----	-----	-----	-----	-----	-----	----	----

Table 5. Least Significant Byte

b7	b6	b5	b4	b3	b2	b1	b0
----	----	----	----	----	----	----	----

memory contents, and the accompanying data bytes are *not* acknowledged, as shown in Figure 5. Each data byte in the memory has a 16-bit (two byte wide) address. The Most Significant Byte (Table 4) is sent first, followed by the Least Significant Byte (Table 5). Bits b15 to b0 form the address of the byte in memory.

When the bus master generates a Stop condition immediately after the Ack bit (in the "10th bit" time slot), either at the end of a Byte Write or a Page Write, the internal memory Write cycle is triggered. A Stop condition at any other time slot does not trigger the internal Write cycle.

During the internal Write cycle, Serial Data (SDA) is disabled internally, and the device does not respond to any requests.

Byte Write

After the Device Select code and the address bytes, the bus master sends one data byte. If the addressed location is Write-protected, by Write Control (WC) being driven High, the device replies with NoAck, and the location is not modified. If, instead, the addressed location is not Write-protected, the device replies with Ack. The bus

Table 6. Operating Modes

Mode	R₩ bit	WC 1	Bytes	Initial Sequence
Current Address Read	1	Х	1	START, Device Select, RW = 1
Random Address Read	0	Х	1	START, Device Select, $R\overline{W} = 0$, Address
Random Address Read	1	Х	<u> </u>	reSTART, Device Select, RW = 1
Sequential Read	1	Х	≥ 1	Similar to Current or Random Address Read
Byte Write	0	V _{IL}	1	START, Device Select, $R\overline{W} = 0$
Page Write	0	V _{IL}	≤ 32	START, Device Select, $R\overline{W} = 0$

Note: 1. $X = V_{IH}$ or V_{IL} .

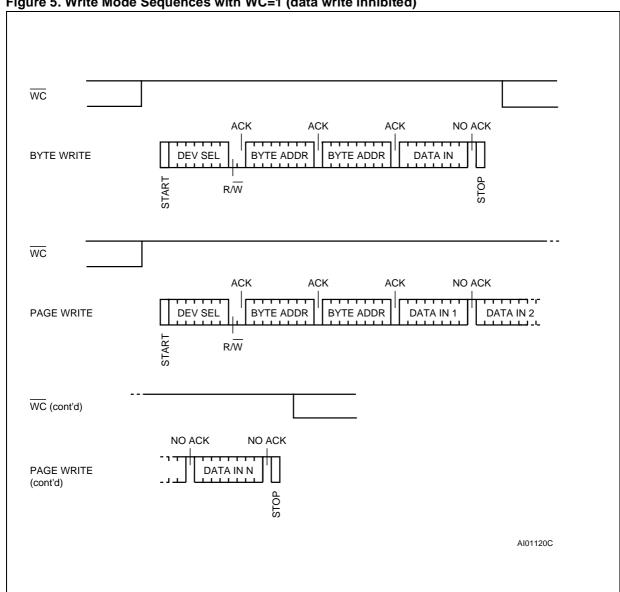


Figure 5. Write Mode Sequences with WC=1 (data write inhibited)

master terminates the transfer by generating a Stop condition, as shown in Figure 6.

Page Write

The Page Write mode allows up to 32 bytes to be written in a single Write cycle, provided that they are all located in the same 'row' in the memory: that is, the most significant memory address bits (b12-b5) are the same. If more bytes are sent than will fit up to the end of the row, a condition known as 'roll-over' occurs. This should be avoided, as data starts to become overwritten in an implementation dependent way.

The bus master sends from 1 to 32 bytes of data, each of which is acknowledged by the device if Write Control (\overline{WC}) is Low. If Write Control (\overline{WC}) is High, the contents of the addressed memory location are not modified, and each data byte is followed by a NoAck. After each byte is transferred, the internal byte address counter (the least significant address bits only) is incremented. The transfer is terminated by the bus master generating a Stop condition.

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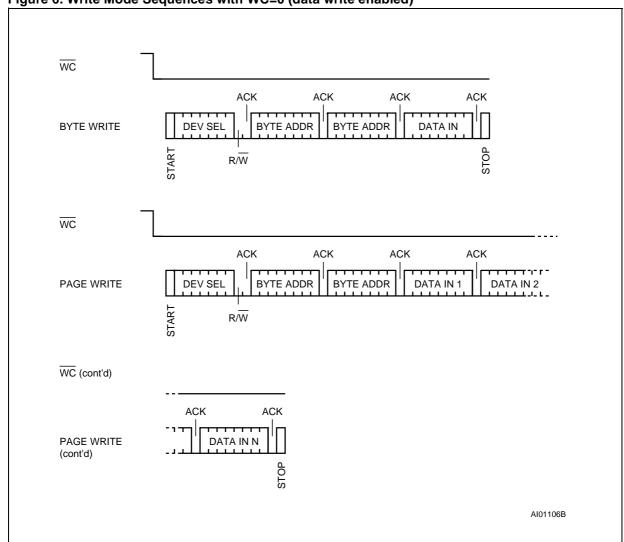


Figure 6. Write Mode Sequences with WC=0 (data write enabled)

Minimizing System Delays by Polling On ACK

During the internal Write cycle, the device disconnects itself from the bus, and writes a copy of the data from its internal latches to the memory cells. The maximum Write time (t_W) is shown in Table 9, but the typical time is shorter. To make use of this, a polling sequence can be used by the bus master.

The sequence, as shown in Figure 7, is:

- Initial condition: a Write cycle is in progress.
- Step 1: the bus master issues a Start condition followed by a Device Select Code (the first byte of the new instruction).
- Step 2: if the device is busy with the internal Write cycle, no Ack will be returned and the bus master goes back to Step 1. If the device has

terminated the internal Write cycle, it responds with an Ack, indicating that the device is ready to receive the second part of the instruction (the first byte of this instruction having been sent during Step 1).

Read Operations

Read operations are performed independently of the state of the Write Control (WC) signal.

Random Address Read

A dummy Write is performed to load the address into the address counter (as shown in Figure 8) but without sending a Stop condition. Then, the bus master sends another Start condition, and repeats the Device Select Code, with the RW bit set to 1. The device acknowledges this, and outputs the

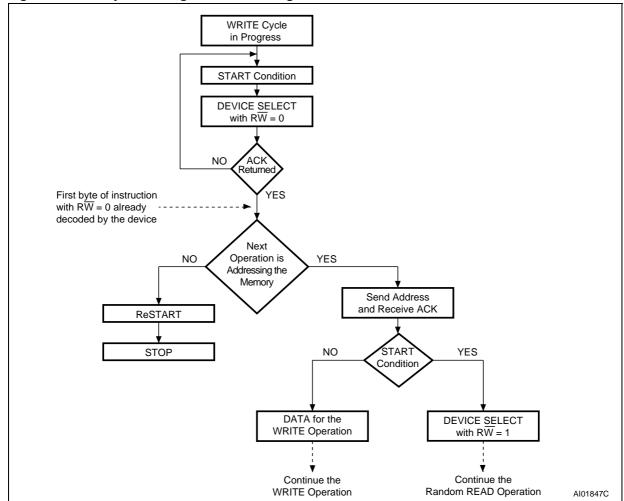


Figure 7. Write Cycle Polling Flowchart using ACK

contents of the addressed byte. The bus master must *not* acknowledge the byte, and terminates the transfer with a Stop condition.

Current Address Read

The device has an internal address counter which is incremented each time a byte is read. For the Current Address Read operation, following a Start condition, the bus master only sends a Device Select Code with the $R\overline{W}$ bit set to 1. The device acknowledges this, and outputs the byte addressed by the internal address counter. The counter is then incremented. The bus master terminates the transfer with a Stop condition, as shown in Figure 8, *without* acknowledging the byte.

Sequential Read

This operation can be used after a Current Address Read or a Random Address Read. The bus master *does* acknowledge the data byte output, and sends additional clock pulses so that

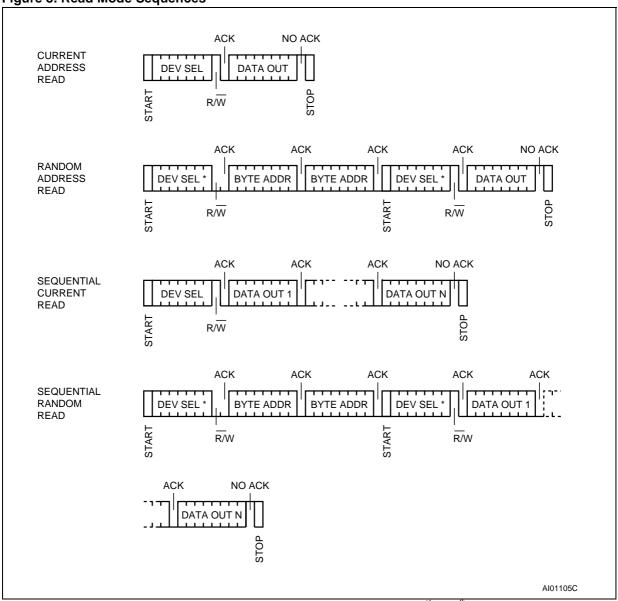
the device continues to output the next byte in sequence. To terminate the stream of bytes, the bus master must *not* acknowledge the last byte, and *must* generate a Stop condition, as shown in Figure 8.

The output data comes from consecutive addresses, with the internal address counter automatically incremented after each byte output. After the last memory address, the address counter 'rolls-over', and the device continues to output data from memory address 00h.

Acknowledge in Read Mode

For all Read commands, the device waits, after each byte read, for an acknowledgment during the 9th bit time. If the bus master does not drive Serial Data (SDA) Low during this time, the device terminates the data transfer and switches to its Stand-by mode.

Figure 8. Read Mode Sequences



Note: 1. The seven most significant bits of the Device Select Code of a Random Read (in the 1st and 4th bytes) must be identical.

Table 7. DC Characteristics $(T_A = -40 \text{ to } 85 \text{ °C}; V_{CC} = 4.5 \text{ to } 5.5 \text{ V}, \text{ or } 2.5 \text{ to } 5.5 \text{ V}, \text{ or } 1.8 \text{ to } 5.5 \text{ V}, \text{ or } 1.8 \text{ to } 3.6 \text{ V})$

Symbol	Parame	ter	Test Condition	Min.	Max.	Unit
ILI	Input Leakage Current (E0-E2, SCL, SDA)		$V_{IN} = V_{SS}$ or V_{CC}		± 2	μA
I _{LO}	Output Leakage C	urrent	$0 \text{ V} \le V_{OUT} \le V_{CC}$, SDA in Hi-Z		± 2	μA
			V_{CC} =5V, f_c =400kHz (rise/fall time < 30ns)		2	mA
	Comple Company	-W series:	V_{CC} =2.5V, f_c =400kHz (rise/fall time < 30ns)		1	mA
I _{CC}	Supply Current	-R series:	$V_{CC} = 1.8V$, $f_c = 400$ kHz (rise/fall time < 30ns)		0.8	mA
		-S series:	V_{CC} =1.8V, f_c =400kHz (rise/fall time < 30ns)		0.8	mA
			$V_{IN} = V_{SS} \text{ or } V_{CC}$, $V_{CC} = 5 \text{ V}$		10	μΑ
	Supply Current -W series:		$V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 2.5$ V		2	μA
ICC1	(Stand-by)	-R series:	$V_{IN} = V_{SS}$ or V_{CC} , $V_{CC} = 1.8$ V		0.2	μA
		-S series:	$V_{IN} = V_{SS} \mbox{ or } V_{CC} , V_{CC} = 1.8 \mbox{ V}$		1	μA
VIL	Input Low Voltage (E0-E2, SCL, SDA	۸)		- 0.3	0.3 V _{CC}	V
V _{IH}	Input High Voltage (E0-E2, SCL, SDA			0.7V _{CC}	V _{CC} +1	V
V _{IL}	Input Low Voltage	(WC)		- 0.3	0.5	V
V _{IH}	Input High Voltage	· (WC)		0.7V _{CC}	V _{CC} +1	V
			$I_{OL} = 3$ mA, $V_{CC} = 5$ V		0.4	V
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	Output Low	-W series:	I_{OL} = 2.1 mA, V_{CC} = 2.5 V		0.4	٧
VOL	V _{OL} Voltage	-R series:	$I_{OL} = 0.7$ mA, $V_{CC} = 1.8$ V		0.2	V
		-S series:	$I_{OL} = 0.7$ mA, $V_{CC} = 1.8$ V		0.2	V

Table 8. Input Parameters¹ ($T_A = 25$ °C, f = 400 kHz)

Symbol	Parameter	Test Condition	Min.	Max.	Unit
C _{IN}	Input Capacitance (SDA)			8	pF
C _{IN}	Input Capacitance (other pins)			6	pF
Z _L	WC Input Impedance	V _{IN} < 0.5 V	5	20	kΩ
Z _H	WC Input Impedance	V _{IN} > 0.7V _{CC}	500		kΩ
t _{NS}	Pulse width ignored (Input Filter on SCL and SDA)	Single glitch		100	ns

Note: 1. Sampled only, not 100% tested.

Table 9. AC Characteristics

			M24C64 / M24C32						
Symbol	Alt.	Parameter		5 to 5.5 V 0 to 85°C	V _{CC} =2.5 or V _{CC} =1 or V _{CC} =1 T _A =-40	Unit			
			Min	Max	Min	Max	7		
t _{CH1CH2}	t _R	Clock Rise Time		300		300	ns		
t _{CL1CL2}	t _F	Clock Fall Time		300		300	ns		
t _{DH1DH2} ²	t _R	SDA Rise Time	20	300	20	300	ns		
t _{DL1DL2} ²	t _F	SDA Fall Time	20	300	20	300	ns		
t _{CHDX} ¹	t _{SU:STA}	Clock High to Input Transition	600		600		ns		
t _{CHCL}	t _{HIGH}	Clock Pulse Width High	600		600		ns		
t _{DLCL}	t _{HD:STA}	Input Low to Clock Low (START)	600		600		ns		
t _{CLDX}	t _{HD:DAT}	Clock Low to Input Transition	0		0		μs		
t _{CLCH}	t _{LOW}	Clock Pulse Width Low	1.3		1.3		μs		
t _{DXCX}	t _{SU:DAT}	Input Transition to Clock Transition	100		100		ns		
t _{CHDH}	t _{SU:STO}	Clock High to Input High (STOP)	600		600		ns		
t _{DHDL}	t _{BUF}	Input High to Input Low (Bus Free)	1.3		1.3		μs		
t _{CLQV} ³	t _{AA}	Clock Low to Data Out Valid	200	900	200	900	ns		
t _{CLQX}	t _{DH}	Data Out Hold Time After Clock Low	200		200		ns		
f _C	f _{SCL}	Clock Frequency		400		400	kHz		
t _W	t _{WR}	Write Time		5 ⁴		10	ms		

Note: 1. For a reSTART condition, or following a Write cycle.

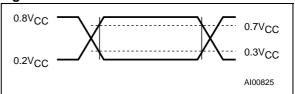
2. Sampled only, not 100% tested.

3. To avoid spurious START and STOP conditions, a minimum delay is placed between SCL=1 and the falling or rising edge of SDA.

Table 10. AC Measurement Conditions

Input Rise and Fall Times	≤ 50 ns
Input Pulse Voltages	0.2V _{CC} to 0.8V _{CC}
Input and Output Timing Reference Voltages	0.3V _{CC} to 0.7V _{CC}

Figure 9. AC Measurement Conditions



To avoid spanded STARY and STOT conditions, a minimum delay is placed between SOL=1 and the failing of rising edge of SDA.
 The Write Time of 5 ms only applies to devices in the 4.5 to 5.5V range bearing the process letter "B" in the package marking (on the top side of the package), otherwise (for devices bearing the process letter "N") the Write Time is 10 ms. For further details, please contact your nearest ST sales office, and ask for a copy of the Product Change Notice PCEE0036.

Figure 10. AC Waveforms

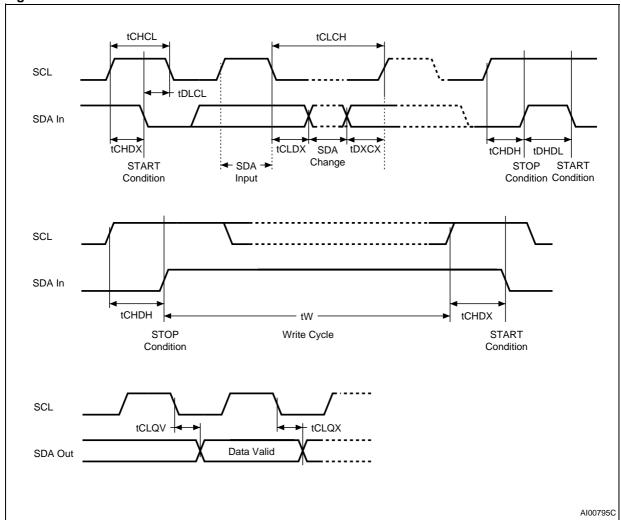
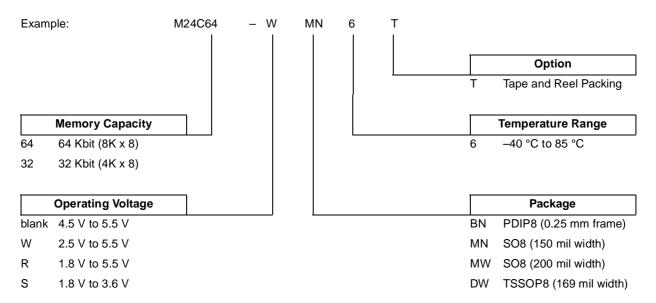


Table 11. Ordering Information Scheme

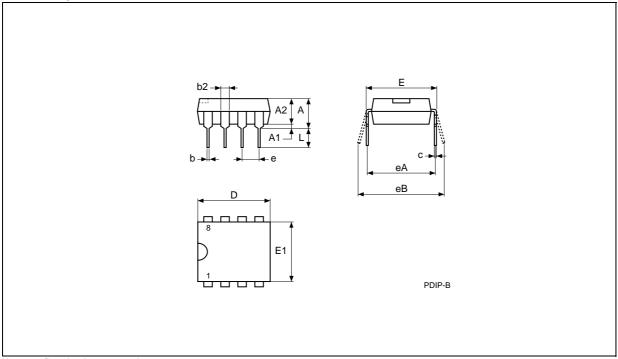


ORDERING INFORMATION

Devices are shipped from the factory with the memory content set at all 1s (FFh).

The notation used for the device number is as shown in Table 11. For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest ST Sales Office.

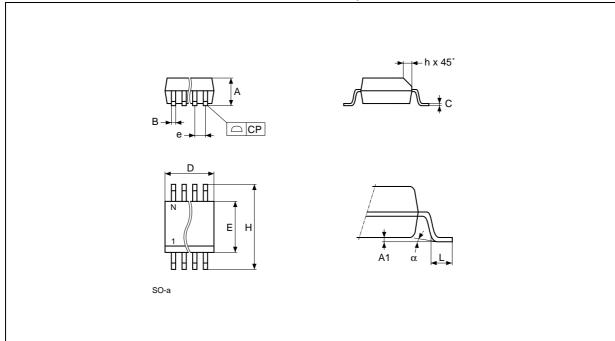
PDIP8 - 8 pin Plastic DIP, 0.25mm lead frame



Note: 1. Drawing is not to scale.

PDIP8 – 8 pin Plastic DIP, 0.25mm lead frame

Symb.		mm		inches			
Syllib.	Тур.	Min.	Max.	Тур.	Min.	Max.	
А			5.33			0.210	
A1		0.38			0.015		
A2	3.30	2.92	4.95	0.130	0.115	0.195	
b	0.46	0.36	0.56	0.018	0.014	0.022	
b2	1.52	1.14	1.78	0.060	0.045	0.070	
С	0.25	0.20	0.36	0.010	0.008	0.014	
D	9.27	9.02	10.16	0.365	0.355	0.400	
E	7.87	7.62	8.26	0.310	0.300	0.325	
E1	6.35	6.10	7.11	0.250	0.240	0.280	
е	2.54	_	_	0.100	_	_	
eA	7.62	_	-	0.300	_	_	
eB			10.92			0.430	
L	3.30	2.92	3.81	0.130	0.115	0.150	



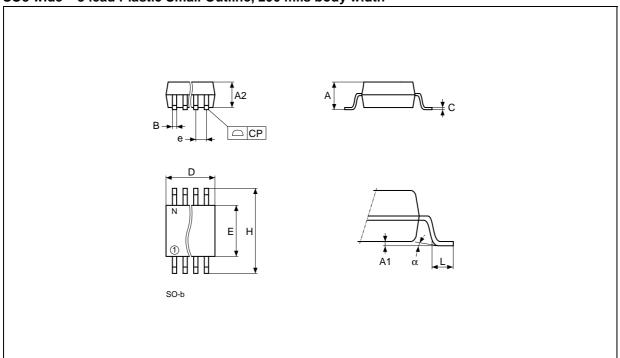
SO8 narrow - 8 lead Plastic Small Outline, 150 mils body width

Note: Drawing is not to scale.

SO8 narrow - 8 lead Plastic Small Outline, 150 mils body width

Symb.		mm		inches			
Symb.	Тур.	Min.	Max.	Тур.	Min.	Max.	
А		1.35	1.75		0.053	0.069	
A1		0.10	0.25		0.004	0.010	
В		0.33	0.51		0.013	0.020	
С		0.19	0.25		0.007	0.010	
D		4.80	5.00		0.189	0.197	
E		3.80	4.00		0.150	0.157	
е	1.27	-	-	0.050	-	-	
Н		5.80	6.20		0.228	0.244	
h		0.25	0.50		0.010	0.020	
L		0.40	0.90		0.016	0.035	
α		0°	8°		0°	8°	
N		8			8		
СР			0.10			0.004	

SO8 wide - 8 lead Plastic Small Outline, 200 mils body width

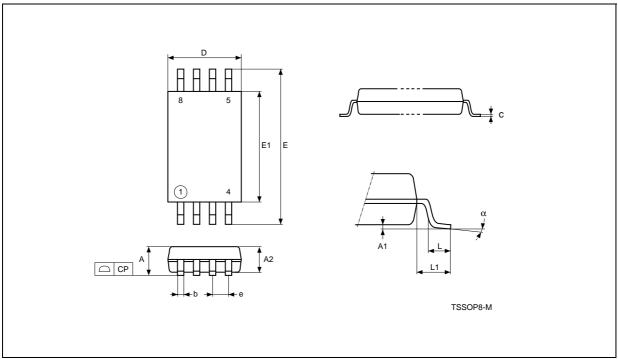


Note: Drawing is not to scale.

SO8 wide - 8 lead Plastic Small Outline, 200 mils body width

Symb.	mm			inches		
	Тур.	Min.	Max.	Тур.	Min.	Max.
А			2.03			0.080
A1		0.10	0.25		0.004	0.010
A2			1.78			0.070
В		0.35	0.45		0.014	0.018
С	0.20	_	-	0.008	-	_
D		5.15	5.35		0.203	0.211
E		5.20	5.40		0.205	0.213
е	1.27	_	-	0.050	-	_
Н		7.70	8.10		0.303	0.319
L		0.50	0.80		0.020	0.031
α		0°	10°		0°	10°
N		8			8	
СР			0.10			0.004

TSSOP8 - 8 lead Thin Shrink Small Outline



Note: 1. Drawing is not to scale.

TSSOP8 - 8 lead Thin Shrink Small Outline

Symbol	mm			inches		
	Тур.	Min.	Max.	Тур.	Min.	Max.
А			1.200			0.0472
A1		0.050	0.150		0.0020	0.0059
A2	1.000	0.800	1.050	0.0394	0.0315	0.0413
b		0.190	0.300		0.0075	0.0118
С		0.090	0.200		0.0035	0.0079
СР			0.100			0.0039
D	3.000	2.900	3.100	0.1181	0.1142	0.1220
е	0.650	-	-	0.0256	-	_
E	6.400	6.200	6.600	0.2520	0.2441	0.2598
E1	4.400	4.300	4.500	0.1732	0.1693	0.1772
L	0.600	0.450	0.750	0.0236	0.0177	0.0295
L1	1.000			0.0394		
α		0°	8°		0°	8°

Table 12. Revision History

Date	Rev.	Description of Revision	
22-Dec-1999	2.3	TSSOP8 package in place of TSSOP14 (pp 1, 2, OrderingInfo, PackageMechData).	
28-Jun-2000	2.4	TSSOP8 package data corrected	
31-Oct-2000	2.5	References to Temperature Range 3 removed from Ordering Information Voltage range -S added, and range -R removed from text and tables throughout.	
20-Apr-2001	2.6	Lead Soldering Temperature in the Absolute Maximum Ratings table amended Write Cycle Polling Flow Chart using ACK illustration updated References to PSDIP changed to PDIP and Package Mechanical data updated	
16-Jan-2002	2.7	Test condition for I _{LI} made more precise, and value of I _{LI} for E2-E0 and WC added -R voltage range added	

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